Notice of References Cited Application/Control No. 10/730,191 Examiner Seung H. Lee Applicant(s)/Patent Under Reexamination SCHRAMM ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,430,286	07-1995	Hammond et al.	235/462.22
	В	US-6,689,998	02-2004	Bremer, Edward C.	250/201.2
	С	US-6,765,857	07-2004	Yoo et al.	369/112.06
	D	US-5,969,323	10-1999	Gurevich et al.	235/462.06
	Е	US-4,867,545	09-1989	Wakimoto et al.	359/663
	F	US-6,269,169	07-2001	Funk et al.	382/100
	G	US-5,315,095	05-1994	Marom et al.	235/462.22
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates, Classifications may be US or foreign.